U.S. Patent and Trademark Office (Lègal Instruments Examiner) Kyung-Hye Shin (Assistant Examiner) CLASS 709 theosen L 370 Issue Classification 709 CLASS 226 389 **CROSS REFERENCE(S)** SUBCLASS (ONE SUBCLASS PER BLOCK) _ Θ °2/2ω/ δ (ρ (Date) ORIGINAL (Date) 9/15/2006 238 (Primary Examiner) Shin, Kyung H 09921832 Application/Control No. Examiner SUBCLASS SUPERVISORY PATENT EXAMINER TOTAND OF CENTER 2100 DAVIDUMLEY, (Date) CLAIMED INTERNATIONAL CLASSIFICATION 2143 Applicant(s)/Patent under Reexamination HONG ET AL. Art Unit 15 / 173 Part of Paper No. O.G. Print Claim(s) **Total Claims Allowed:** NON-CLAIMED 38 O.G. Print FIG. 5